## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10633617	SHIN ET AL.
Examiner	Art Unit
Nhon T Diep	2621

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SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East search	6/8/2008	ND
Consulted w/ 2621 during QAM	2/12/2009	ND

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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